

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/623,453	YEH, MING-TIEN	
		Examiner	Art Unit	Page 1 of 1
		David C. Reese	3677	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,708,552	11-1987	Bustos et al.	411/80.1
	B	US-3,765,295	10-1973	Ptak, Wilbur F.	411/41
	C	US-4,050,344	09-1977	Dorgnon, Roger	411/30
	D	US-5,221,167	06-1993	Girkin et al.	411/45
	E	US-5,030,051	07-1991	Kaneko et al.	411/55
	F	US-3,691,924	09-1972	Baker, William H.	411/30
	G	US-5,540,528	07-1996	Schmidt et al.	411/55
	H	US-5,779,415	07-1998	Hoene, Jochen	411/358
	I	US-5,575,600	11-1996	Giannuzzi et al.	411/48
	J	US-6,324,731 B1	12-2001	Pliml, Jr., Frank V.	24/453
	K	US-4,182,218	01-1980	Combette et al.	411/80.1
	L	US-4,917,552	04-1990	Crawford, Danny E.	411/32
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.